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Test report No: 6041647.50

TEST REPORT

Electromagnetic Compatibility (EMC)

Identification of item tested	Diamond Core Drill		
Identification of item tested			
Trademark	AGP		
Model and /or type reference	DM6P; DBM200-3; EVO2 PWD; EVO2 DWD; EVO2 PW; EVO2 DW; MCM200; KDMM2000; MT-19A; MT-19P; MT-18P; MT-18A; CAR201; QDM-150D; QDM-150W; C-BMH-160; BB1004; HSD-6P; DM6D; DMC6P; DMC6D; DM62; DD62; DD160; EVO20-PDSI; MDB-180P		
Ratings	DM6P; DBM200-3; EVO2 PWD; EVO2 DWD; EVO2 PW; EVO2 DW; MCM200; KDMM2000; MT-19A; MT-19P; MT-18P; MT-18A; CAR201; QDM-150D; QDM-150W; C-BMH-160; BB1004; HSD-6P; DM6D; DMC6P; DMC6D: 220-240 V; 50-60 Hz; 2000 W; n_0 =930/1520/4270 min ⁻¹ ; Class I 110-120 V; 50-60 Hz; 1700 W; n_0 =930/1520/4270 min ⁻¹ ; Class I DM62; DD62; DD160; EVO20-PDSI; MDB-180P: 220-240 V; 50-60 Hz; 2000 W; n_0 =1250/1900 min ⁻¹ ; Class I 110-120 V; 50-60 Hz; 1700 W; n_0 =1250/1900 min ⁻¹ ; Class I		
Test Laboratory / address	DEKRA Testing and Certification (Shanghai) Ltd. No. 250 Jiangchangsan Road Shibei Hi-Tech Park, 200436 Zhabei District, Shanghai, China		
Applicant's name / address	LEE YEONG INDUSTRUAL CO., LTD. No.2, Kejia Rd., Douliu City, Yunlin County 64057, Taiwan		
Test method requested, standard	EN 55014-1:2006+A1:2009+A2:2011; EN 55014-1:2017 EN 55014-2:2015 EN 61000-3-2:2014; EN 61000-3-3:2013		
Verdict Summary	IN COMPLIANCE		
Tested by	Kaiyuan Dai (Project Engineer) Kaiyuan Dai		
Approved by	Zuyao Fan (Project Manager) Zuyaw. Fan		

Date of issue	2018-11-29
Report template No	TRF-EMC-2018 V1.0

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COMPETENCES AND GUARANTEES

DEKRA is a testing laboratory competent to carry out the tests described in this report.

In order to assure the traceability to other national and international laboratories, DEKRA has a calibration and maintenance program for its measurement equipment.

DEKRA guarantees the reliability of the data presented in this report, which is the result of the measurements and the tests performed to the item under test on the date and under the conditions stated in the report and it is based on the knowledge and technical facilities available at DEKRA at the time of performance of the test.

DEKRA is liable to the client for the maintenance of the confidentiality of all information related to the item under test and the results of the test.

The results presented in this Test Report apply only to the particular item under test established in this document.

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GENERAL CONDITIONS

- 1. This report is only referred to the item that has undergone the test.
- 2. This report does not constitute or imply on its own an approval of the product by the Certification Bodies or Competent Authorities.
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UNCERTAINTY

For all measurements where guidance for the calculation of the instrumentation uncertainty of a measurement is specified in EN 55016-4-2 (CISPR 16-4-2), EN/IEC 61000-4 series or a product standard, the measurement instrumentation uncertainty has been calculated and applied in accordance with these standards.

Uncertainties have been calculated according to the DEKRA internal document. The reported expanded uncertainties are based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95%. Refer to the Annex 1 for furter information.

ENVIRONMENTAL CONDITIONS

The climatic conditions during the tests are within the limits specified by the manufacturer for the operation of the EUT and the test equipment. The climatic conditions during the tests were within the following limits:

Ambient temperature	15 °C – 35 °C
Relative Humidity air	30% - 60%
Atmospheric pressure	86 kPa – 106 kPa

If explicitly required in the basic standard or applied product / product family standard the climatic values are recorded and documented separately in this test report.

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POSSIBLE TEST CASE VERDICTS

Test case does not apply to test object	N/A
Test object does meet requirement	P (Pass) / PASS
Test object does not meet requirement	F (Fail) / FAIL
Not measured	N/M

DEFINITION OF SYMBOLS USED IN THIS TEST REPORT

☑ Indicates that the listed condition, standard or equipment is applicable for this report/test/EUT.			
☐ Indicates that the listed condition, standard or equipment is not applicable for this report/test/EUT.			
Decimal separator used in this report Comma (,) Point (.)			

ABBREVIATIONS

For the purposes of the present document, the following abbreviations apply:

EUT : Equipment Under Test

QP : Quasi-Peak
CAV : CISPR Average

AV : Average

CDN : Coupling Decoupling Network SAC : Semi-Anechoic Chamber

OATS : Open Area Test Site

BW: Bandwidth

AM : Amplitude Modulation
PM : Pulse Modulation

HCP : Horizontal Coupling PlaneVCP : Vertical Coupling Plane

U_N : Nominal voltage

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DOCUMENT HISTORY

Report nr.	Date	Description
6041647.50	2018-11-29	First release.

Modification -1 report:

The report is issued to base on original test report Ref. No. 6010548.50 dated on 2017-07-26 including the following modifications:

- Add new types. New types are same as previous types.
- Vibration retest according to instructions. (with 80 mm drill bit)

After review, no test is considered necessary.

REMARKS AND COMMENTS

The equipment under test (EUT) does meet the requirements of the stated standard(s)/test(s).

The test results relate only to the samples tested.

The RF function was not part of this EMC assessment.

According to the declaration from manufacturer, DM6P; DBM200-3; EVO2 PWD; EVO2 DWD; EVO2 PW; EVO2 DW; MCM200; KDMM2000; MT-19A; MT-19P; MT-18P; MT-18A; CAR201; QDM-150D; QDM-150W; C-BMH-160; BB1004; HSD-6P; DM6D; DMC6P; DMC6D; DM62; DD62 and DD160; EVO20-PDSI; MDB-180P are identical. The difference for DM6P; DBM200-3; EVO2 PWD; EVO2 DWD; EVO2 PW; EVO2 DW; MCM200; KDMM2000; MT-19A; MT-19P; MT-18P; MT-18A; CAR201; QDM-150D; QDM-150W; C-BMH-160; BB1004; HSD-6P; DM6D; DMC6P; DMC6D and DM62; DD62; DD160; EVO20-PDSI; MDB-180P is only the rated no-load speed due to the ratio of the gear box is different. The handles of these models can be D or P type

Therefore, model DM6D was selected for the full tests and the results are also representative for other models as well.

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1 **GENERAL INFORMATION**

1.1 General Description of the Item(s)

Description of the item:	Diamond Core Drill
Model / Type number:	DM6D
Representative Type:	DM6P; DBM200-3; EVO2 PWD; EVO2 DWD; EVO2 PW; EVO2 DW; MCM200; KDMM2000; MT-19A; MT-19P; MT-18P; MT-18A; CAR201; QDM-150D; QDM-150W; C-BMH-160; BB1004; HSD-6P; DM6D; DMC6P; DMC6D; DM62; DD160; EVO20-PDSI; MDB-180P
Trademark:	AGP
Manufacturer:	LEE YEONG INDUSTRIAL CO., LTD.
	No.2, Kejia Rd., Douliu City, Yunlin County 64057, Taiwan
Factory:	LEE YEONG INDUSTRIAL CO., LTD.
	No.2, Kejia Rd., Douliu City, Yunlin County 64057, Taiwan

Rated power supply::	Voltage and Frequency	Reference poles		
	Voltage and Frequency	L1 L2 L3 N PE		
	AC: 110-120 V, 50-60 Hz			
	DC: 12 V, 24 V, 12 / 24 V			
	Battery:			
Rated Power:	DM6P; DBM200-3; EVO2 PWD; EVO2 DV	VD; EVO2 PW; EVO2 DW;		
	MCM200; KDMM2000; MT-19A; MT-19P;	MT-18P; MT-18A; CAR201;		
	QDM-150D; QDM-150W; C-BMH-160; BB	1004; HSD-6P; DM6D;		
	DMC6P; DMC6D:			
	220-240 V; 50-60 Hz; 2000 W; n ₀ =930/1520/4270 min ⁻¹ ; Class I			
	110-120 V; 50-60 Hz; 1700 W; n ₀ =930/1520/4270 min ⁻¹ ; Class I			
	DM62; DD62; DD160; EVO20-PDSI; MDB-180P:			
	220-240 V; 50-60 Hz; 2000 W; n ₀ =1250/1900 min ⁻¹ ; Class I			
	110-120 V; 50-60 Hz; 1700 W; n ₀ =1250/19	900 min ⁻¹ ; Class I		
Clock frequencies:	Not provided			
Other parameters:	N/A			
Mounting position:	Table top equipment			
	☐ Wall/Ceiling mounted equipment			
	Floor standing equipment			
	Other:			

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Intended use of the Equipment Under Test (EUT)

This machine is for the intended purpose of diamond core drilling of concrete, masonry, stone and similar materials.

No	Module/parts of test item	Туре	Manufacturer
No	Documents as provided by the applicant - Description	File name	Issue date

Copy of marking plate: iamond Core Drill iamond Core Dri Model: DM62 Model: DM62 220-240V~ 50-60Hz 2000W n₀=1250/1900 min⁻¹ 110-120V~ 50-60Hz 1700W n_o=1250/1900 min⁻¹ Rated Load Speeds min -1: Speed 1: 750 / Speed 2: 1140 Rated Load Speeds min -1: Speed 1: 750 / Speed 2: 1140 Capacity-Dry: 162mm (6-1/4") Capacity-Dry: 162mm (6-1/4") Lee Yeong Ind. Co., Ltd. Lee Yeong Ind. Co., Ltd. No. 2, Kejia Rd., Douliu, 64057 Taiwan No. 2, Kejia Rd., Douliu, 64057 Taiwan No.: No.:

Note: Marking labels of DM6P; DBM200-3; EVO2 PWD; EVO2 DWD; EVO2 PW; EVO2 DW; MCM200; KDMM2000; MT-19A; MT-18P; MT-18A; CAR201; QDM-150D; QDM-150W; C-BMH-160; BB1004; HSD-6P; DM6D; DMC6P; DMC6D; DM62; DD62; DD160; EVO20-PDSI; MDB-180P are same, only the rated no-load speed is different due to different ratio of gear box.

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1.2 **Environment**

The requirements and standards apply to equipment intended for use in:

\boxtimes	Residential (domestic) environment.
\boxtimes	Commercial and light-industrial environment.
	Industrial environment.

1.3 **Test Location**

DEKRA Shanghai

Location	Global Certification Corp.
Address	No.146, Sec. 2, Xiangzhang Rd., Xizhi Dist., New Taipei City 221,
Address	Taiwan
Date	July 2017
Supervised by	Zuyao Fan

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1.4 Classification according to EN 55014-2

The standard EN 55014-2 is subdivided in four categories. For each category, specific immunity requirements are formulated.

Category I: Apparatus containing no electronic control circuitry.
<u>Examples:</u> Motor operated appliances, lighting toys, track sets without electronic control units, tools, heating appliances, UV and IR radiators and apparatus containing components such as electromechanical switches and thermostats.
Electric circuits consisting of passive components (such as radio interference suppression capacitors or inductors, mains transformers and mains frequency rectifiers) are not considered to be electronic control circuitry.
<u>Category II:</u> Transformer toys, dual supply toys, mains powered motor operated appliances, tools, heating appliances and similar electric apparatus (for example – UV radiators, IR radiators and microwave ovens) containing electronic control circuitry with no internal clock frequency or oscillator frequency higher than 15 MHz.
<u>Category III:</u> Battery powered apparatus (with built-in batteries or external batteries), which in normal use is not connected to the mains, containing an electronic control circuitry with no internal clock frequency or oscillator frequency higher than 15 MHz.
Category IV: All other apparatus covered by the scope of the EN 55014-2 standard.
 equency: Fundamental frequency of any signal used in the device, excluding those which are solely de integrated circuits (IC).

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2 **DESCRIPTION OF TEST SETUP**

2.1 Operating mode(s) used for tests

During the tests the following operating mode(s) has(have) been used.

Operating mode	Operating mode description	Used for testing			
mode Operating mode description		Emission	Immunity		
1	Normal operation	\boxtimes	\boxtimes		
2					
3					
4					
5					
6					
Supplemental information:					

2.2 Port(s) of the EUT

	Connected to /	Cable			
Port name and description	Termination	Length used during test [m]	Attached during test	Shielded	
AC mains input	AC mains	≥ 2 m			
Supplemental information:					

2.3 Support / Auxiliary equipment / unit / software for the EUT

The EUT has been tested with the following auxiliary equipment / unit / software:

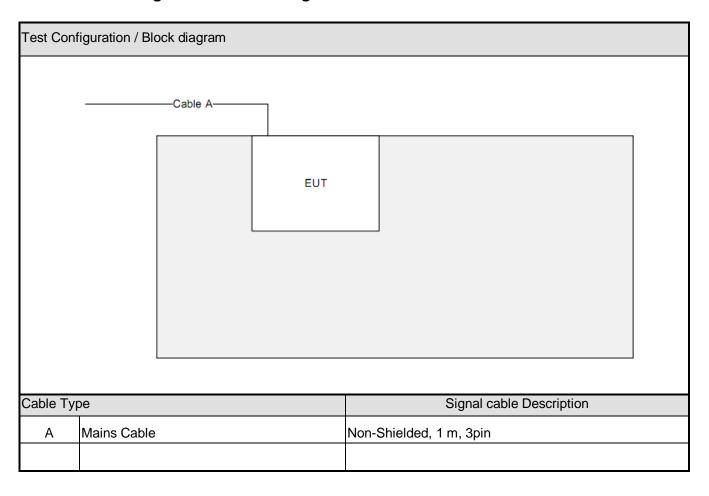
Auxiliary equipment / unit / software	Type / Version	Manufacturer	Supplied by
N/A			
Supplemental information:			

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2.4 Test Configuration / Block diagram used for tests



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3 **VERDICT SUMMARY SECTION**

This chapter presents an overview of standards and results. Refer to the next chapters for details of measured test results and applied test levels.

3.1 **Standards**

Standard	Year	Description
EN 55014-1	2006	Requirements for household appliances, electric tools and similar apparatus -
+A1	2009	Part 1: Emission.
+A2	2011	
EN 55014-1	2017 1)	
EN 55016-2-1	2014	Methods of measurement of disturbances and immunity - Conducted
		disturbance measurements.
EN 55016-2-2	2010	Methods of measurement of disturbances and immunity – Measurement of
		disturbance power.
EN 61000-3-2	2014	Limits for harmonic current emissions (equipment input current ≤ 16 A per
		phase).
EN 61000-3-3	2013	Limitation of voltage changes, voltage fluctuations and flicker in public low-
		voltage supply systems, for equipment with rated current ≤ 16 A per phase and
		not subject to conditional connection.
EN 55014-2	2015 ¹⁾	Requirements for household appliances, electric tools and similar apparatus –
		Part 2: Immunity – Product family standard.
EN 61000-4-2	2009	Electrostatic discharge immunity test.
EN 61000-4-4	2012	Electrical fast transient/burst immunity test.
EN 61000-4-5	2014	Surge immunity test.
EN 61000-4-6	2014	Immunity to conducted disturbances, induced by radio-frequency fields.
EN 61000-4-11	2004	Voltage dips, short interruptions and voltage variations immunity tests.

¹⁾ Not harmonized yet.

3.2 Deviation(s) from the Standard(s) / Test Specification(s)

No deviation.

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3.3 Overview of results

EMISSION TESTS – EN 55014-1							
Requirement – Test case Basic standard(s) Verdict Remark							
Conducted disturbance voltage at mains terminals (150 KHz – 30 MHz)	EN 55016-2-1	PASS					
Disturbance power (30 MHz to 300 MHz)	EN 55016-2-2	PASS	See 2)				
Discontinuous disturbance (clicks) on AC power leads	EN 55014-1	N/A	See 1)				

Supplementary information:

- 1) Exemptions from click measurements applicable (clause 4.2.3).
- 2) According to clause 4.1.2.3.2 procedure (a) of the EN 55014-1 standard the EUT is deemed to comply in the frequency range from 300 MHz to 1000 MHz without further measurements.

EMISSION TESTS – EN 61000-3-2, EN 61000-3-3								
Requirement – Test case Basic standard(s) Verdict Remark								
Harmonic current emissions	EN 61000-3-2	PASS						
Voltage changes, voltage fluctuations and flicker	EN 61000-3-3	PASS						
Supplementary information:								

IMMUNITY TESTS – EN 55014-2						
Requirement – Test case Basic standard(s) Verdict F						
Electrostatic discharge	EN 61000-4-2	PASS				
Fast transients	EN 61000-4-4	PASS				
Surge transient	EN 61000-4-5	PASS				
Injected currents (radio-frequency common mode)	EN 61000-4-6	PASS				
Voltage dips and short interruptions	EN 61000-4-11	PASS				
Supplementary information:		•				

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4 EMISSION TEST RESULTS

4.1 Conducted di	sturba	ance voltage - M	ains			VI	ERDIC	Γ: PASS
Standard	EN 5	5014-1						
Basic standard	EN 5	EN 55016-2-1						
_imits - Tools								
Frequency range [MHz]	Liı	mit: QP [dB(μV) ¹⁾]	Li	mit: A	V [dB(μV) ¹⁾]	IF	- BW	Detector(s)
0,15 - 0,35		66 – 56 ²⁾		59	- 46 ²⁾	9	KHz	QP, CAV
0,35 - 5,0		56		46		9	KHz	QP, CAV
5,0 - 30		60		50		9	KHz	QP, CAV
 At the transition frequency, the lower limit applies. The limit decreases linearly with the logarithm of the frequency. 								
Rated power below 70	00 W		Lim	its as a	above			
☐ Rated power between	700 ar	00 and 1000 W Limits +4 dB						
Rated power above 1	000 W		Lim	its +10	dB			
Performed measurements								
Scan range (0,9 - 1,1 <i>U</i> _N)		198 – 264 V _{AC}			207 – 253 V _{AC}			230 V _{AC}
Tested terminal(s) / port		AC mains input pow	ver	\boxtimes	N 🛭 L	.1		2 🔲 L3
		DC mains input pov	ver		Positive (+)		□N	egative (-)
Voltage – Mains [V]	264 \	√ac				•		
Frequency – Mains [Hz]	50 H	Z						
Test method applied		Artificial mains netw	ork/					
		Voltage probe						
Test setup		☐ Table top ☐ Artificial hand applied						
		Floor standing			Other:			
	Refer to the Annex 3 for test setup photo(s).							
Operating mode(s) used	Mode	e 1						
Remark								

See next page.

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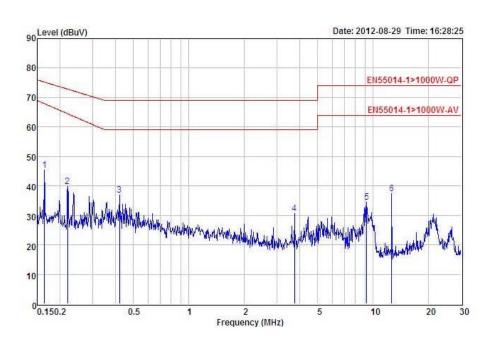
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Measurement data	Port under test	AC mains power input
Operating mode / voltage / frequency used during the test		Mode 1/ 264 Vac/ 50 Hz

Line



	Freq	Read Level	Level	Factor	0ver Limit	Limit Line	Remark
-	MHz	dBu∀	dBu∀	dB	dB	dBu∀	
1	0.16	45.54	45.44	-0.10	-29.82	75.26	Peak
2	0.22	39.89	39.78	-0.11	-33.07	72.85	Peak
3	0.42	37.06	36.93	-0.13	-32.07	69.00	Peak
4	3.74	30.85	30.56	-0.29	-38.44	69.00	Peak
5	9.20	34.97	34.54	-0.43	-39.46	74.00	Peak
6	12.58	38.00	37.49	-0.51	-36.51	74.00	Peak

Remark

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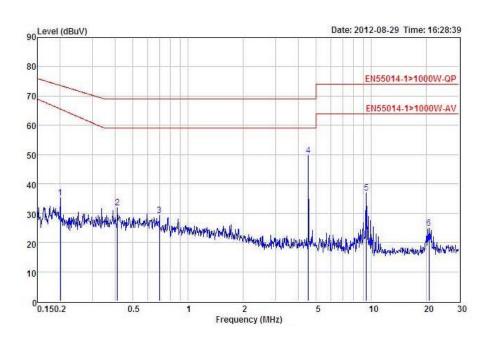
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Measurement data	Port under test	AC mains power input
Operating mode / voltage / frequency used	Mode 1/ 264 Vac/ 50 Hz	

Neutral



	Freq	Read Level	Level	Factor	Over Limit	Limit Line	Remark
-	MHz	dBu∀	dBu∀	dB	dB	dBu∀	
1	0.20	35.39	35.28	-0.11	-38.31	73.59	Peak
2	0.41	31.87	31.74	-0.13	-37.26	69.00	Peak
3	0.70	29.40	29.25	-0.15	-39.75	69.00	Peak
4	4.53	49.91	49.59	-0.32	-19.41	69.00	Peak
5	9.40	37.23	36.80	-0.43	-37.20	74.00	Peak
6	20.59	25.57	24.93	-0.64	-49.07	74.00	Peak

Remark

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4.2 Disturbance po	wer (3	30 MF	lz – 300 MHz)			٧	ERDI	CT:	PASS
Standard	EN 5	5014-	1							
Basic standard	EN 5	5016-2	2-2							
Limits - Tools										
Frequency range [MHz]	Limit	: QP [d	dB(pW)]	Limit: A	√ [dB(p	W)]	ı	F BW		Detector(s)
30 - 300		45 -	- 55 ¹⁾	35	_	45 ¹⁾	12	20 KHz	<u>. </u>	QP, CAV
	•		Margir	1			•			
200 - 300		0 -	- 10 ¹⁾				12	20 KHz	<u>. </u>	QP, CAV
1) The limit increases linearly with the	e frequenc	су.								
Rated power below 7	00 W						Lim	its as a	abov	e
☐ Rated power between	☐ Rated power between 700 and 1000 W Limits +4 dB									
□ Rated power above 1	000 W						Lim	its +10	dB	
Performed measurements										
Port(s) under test										
			Load				Contr	ol		
Other:			Other:				Othe	Other:		
Scan range (0,9 - 1,1 <i>U</i> _N)		198 -	– 264 V _{AC}		207 -	- 253 \	/ _{AC}		2:	30 V _{AC}
Voltage – Mains [V]	264 \	Vac								
Frequency – Mains [Hz]	50 H	Z								
Test setup	etup 🛛 Table top 🔲 Floor standing				ing					
Other:										
	Refer to the Annex 3 for test setup photo(s).									
Conditions for exemption		"Limi	its" reduced by "l	Margin" a	pplied a	and pa	ssed			
from measurements above 300 MHz		Maxi	mum clock frequ	iency < 30) MHz					
Operating mode(s) used	Mode	e 1								
Remark										

See next page.

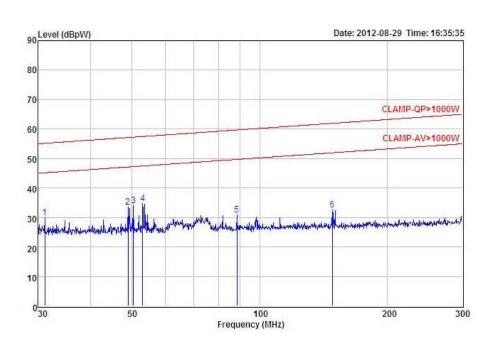
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Measurement data	Port under test	AC mains power input
Operating mode / voltage / frequency used during the test		Mode1/ 264 Vac/ 50 Hz



	Freq	Read Level	Level	Factor	Over Limit	Limit Line	Remark
-	MHz	dBp₩	dBp₩	dB	dB	dBp₩	
1	31.13	11.66	29.89	18.23	-25.28	55.17	Peak
2	48.99	16.42	33.63	17.21	-23.51	57.14	Peak
3	50.36	16.82	33.95	17.13	-23.31	57.26	Peak
4	52.98	17.42	34.77	17.35	-22.71	57.48	Peak
5	88.33	15.12	30.81	15.69	-28.89	59.70	
6	148.29	17.97	32.58	14.61	-29.37	61.95	Peak

Remark

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4.3	Harmonic cur	rent er	missions				VERDICT:		PASS
Standa	rd	EN 610	000-3-2						
Exlusio	ns		Arc welding equ	uipment	t intended for	professiona	ıl use.		
	ese categories of		System(s) with	System(s) with nominal voltage(s) less than 220 V _{AC} (line-to-neutral).					
	ent, limits are not ed in the EN 61000-		Equipment with	rated p	ower of ≤ 75	W (other th	an lighting equip	ome	ent).
3-2 star	ndard)		Professional eq	uipmer	nt with total ra	ted power >	1 kW.		
			Symmetrically of	controlle	ed heating ele	ments with	a rated power ≥	: 20	0 W.
			Independent dir	nmers	for incandesc	ent lamps w	vith rated power	≤ 1	kW.
		ı							
Classifi	cation								
	Class A	All apparatus not classified as Class B, C or D							
\boxtimes	Class B	Portab	le tools						
			☐ Lighting equipment with active input power > 25 W						
	Class C		Lighting equipment with active input power ≤ 25 W						
			(First requirement, Table 3 column 2)						
		Ш	Lighting equipment with active input power ≤ 25 W (Second requirement)						
	Class D	Persor	nal computers, te	levision	receivers				
Perform	ed measurements								
Port un	der test	AC ma	ins power input						
Voltage	- Mains [V]	230 Va	ac						
Freque	ncy – Mains [Hz]	50 Hz							
Observa	ation peroid		6.5 min.	\boxtimes	2.5 min.		Other:		
	of measurement	\boxtimes	EN 61000-4-7:2	2002 +	AM1:2009 (IE	C 61000-4-	7:2002+AM1:20)08))
	ent standard used C61000-4-7 (Cl. 7)		EN 61000-4-7:1	1991					
Control	principle used in	\boxtimes	Comply with the	e requir	ements of the	Clause 6.1	(EN / IEC 6100	0-3	5-2).
the EU			Not comply with	the re	quirements of	the Clause	6.1 (EN / IEC 6	310C	0-3-2).
Operati	ng mode(s) used	Mode	1						
Remark	(

See next page.

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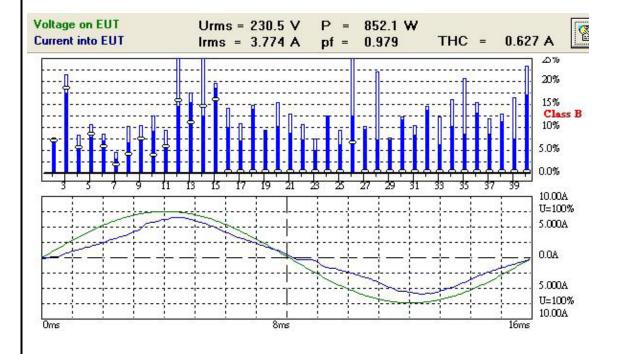
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Measurement data	Port under test	AC mains power input
Operating mode / voltage / frequency used	Mode 1/ 230 Vac/ 50 Hz	

Urms = 230.5V Freq = 60.056 Range: 10 A Irms = 3.774A Ipk = 6.646A cf = 1.761 P = 852.1W S = 870.0VA pf = 0.979 THDi = 16.6 % THDu = 0.20 % Class B

Test completed, Result: PASSED



Remark

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Measurement data	Port under test	AC mains power input
Operating mode / voltage / frequency used of	during the test	Mode 1/ 230 Vac/ 50 Hz
Order Freq. Iavg Irms Imax Li [Hz] [A] [A] [A] [A] [A] 1 60 3.8212 3.7274 4.1522 2 120 0.1067 0.1074 0.1184 1.6 3 180 0.6293 0.5884 0.7275 3.4 4 240 0.0341 0.0354 0.0513 0.6 5 300 0.1398 0.1294 0.1770 1.7 6 360 0.0246 0.0305 0.0366 0.4 7 420 0.0159 0.0311 0.0482 1.1 8 480 0.0130 0.0214 0.0336 0.3 9 540 0.0429 0.0439 0.0598 0.6 10 600 0.0100 0.0244 0.0336 0.2 11 660 0.0269 0.0269 0.0446 0.4 12 720 0.0355 0.0330 0.0592 0.2 13 780 0.0335 0.0476 0.0537 0.3 14 840 0.0281 0.0238 0.0507 0.3 15 900 0.0352 0.0409 0.0433 0.2 16 960 0.0000 0.0165 0.0238 0.1 17 1020 0.0000 0.0165 0.0238 0.1 17 1020 0.0000 0.0159 0.0159 0.1 20 1200 0.0000 0.0134 0.0208 0. 21 1260 0.0000 0.0134 0.0208 0. 21 1260 0.0000 0.0134 0.0208 0. 22 1320 0.0000 0.0085 0.0128 0. 23 1380 0.0000 0.0067 0.0104 0.	imit Status 200 500 450 100 500 550 450 000 2760 4950 2300 8150 1971 2250 1725 1985 1533 1776 1380 1607 1255	Mode 1/ 230 Vac/ 50 Hz
24 1440 0.0000 0.0140 0.0140 0. 25 1500 0.0000 0.0079 0.0122 0.13 26 1560 0.0065 0.0128 0.0275 0.14 27 1620 0.0000 0.0116 0.0122 0.13 28 1680 0.0000 0.0067 0.0214 0.03 29 1740 0.0000 0.0079 0.0085 0.13 30 1800 0.0000 0.0104 0.0110 0.03 31 1860 0.0000 0.0164 0.0110 0.03 32 1920 0.0000 0.0116 0.0122 0.03 33 1980 0.0000 0.0061 0.0122 0.14 34 2040 0.0000 0.0079 0.0128 0.03 35 2100 0.0000 0.0079 0.0128 0.03 36 2160 0.0000 0.0079 0.0195 0.03 37 2220 0.0000 0.0079 0.0196 0.03 38 2280 0.0000 0.0079 0.0092 0.03 39 2340 0.0000 0.0061 0.0140 0.03 40 2400 0.0000 0.0116 0.0159 0.03	1150 350 062 250 986 164 920 089 862 023 812 964 767 912	

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4.4 Voltage changes	s, volta	age fluctuations and	d flicker		VERDICT:	PASS					
Standard	EN 61	1000-3-3									
imits											
P _{ST} (Short term flicker)		≤ 1	\boxtimes	Not Applic	cable						
P _{LT} (Long term flicker)		≤ 0,65	\boxtimes	Not Applic	cable						
d _C (Relative Voltage change)	\boxtimes	≤ 3,3%		Not Applic	cable						
d _{MAX} (Max. voltage change)		≤ 4%		6%							
	\boxtimes	7%		Not Applic	cable						
Supplemental information:					-						
the measurement(s) Port under test	AC Ma	significant voltage fluct	uations or f	ilicker (clau	se 6.1).						
Voltage – Mains [V]	230 Va										
Frequency – Mains [Hz]	50 Hz										
Test method		Flickermeter according	EN / IEC (61000-4-15	:2011						
		Simulation (Clause 4.2	Simulation (Clause 4.2.3 of EN / IEC 61000-3-3)								
		Analytical method (Clause 4.2.4 of EN / IEC 61000-3-3)									
		Analytical method (Cla			· · · · · · · · · · · · · · · · · · ·						
		Analytical method (Claubse of $P_{st} = 1$ curve (C	use 4.2.4 o	of EN / IEC (61000-3-3)						
Observation peroid		Use of $P_{st} = 1$ curve (C	use 4.2.4 o	of EN / IEC (61000-3-3)						
Observation peroid		Use of $P_{st} = 1$ curve (C	use 4.2.4 o lause 4.2.5 20 min.	of EN / IEC 6	61000-3-3) C 61000-3-3)						
Observation peroid Operating mode(s) used	□ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □	Use of $P_{st} = 1$ curve (C 10 min. \square 12 24 times switching according	use 4.2.4 o lause 4.2.5 20 min.	of EN / IEC 6	61000-3-3) C 61000-3-3)						

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Measurement data	Port under test	AC mains power input
Operating mode used during the test	Mode1/ 230 Vac/ 50 Hz	

Tmax (dt > 3,3%)	0,0 ms
Maximum voltage change d _{MAX}	2,125%
Relative Voltage change d _C	0,873%
Short term flicker P _{ST}	Not applicable*
Long term flicker P _{LT}	Not applicable*

Remark

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5 IMMUNITY TEST RESULTS

5.1 Performance (Compliance) criteria

[According to EN 55014-2 (CISPR 14-2)]

<u>Performance criteria A:</u> The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer when the apparatus is used as intended. If the minimum performance level or the permissible performance loss is not specified by the manufacturer then either of these may be derived from the product description and documentation and from what the user may reasonably expect from the apparatus if used as intended.

<u>Performance criteria B</u>: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer when the apparatus is used as intended. During the test, degradation of performance is allowed however no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer then either of these may be derived from the product description and documentation and from what the user may reasonable expect from the apparatus if used as intended.

<u>Performance criteria C</u>: Temporary loss of function is allowed provided the function is self- recoverable or can be restored by the operation of the controls or by any operation specified in the instruction for use.

5.1.1 Performance criteria related to immunity tests

Immunity test	Performance criteria
Electrostatic discharge	В
Fast transients	В
Surge transient	В
Injected currents (radio-frequency common mode)	A
Voltage dips and short interruptions	С

5.1.2 Manufacturer defined performance criteria

Not provided.

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5.2 Monitored – Checked Functions / Parameters

During the immunity tests the following functions of the EUT has/have been monitored/checked.

\boxtimes	Motor speed	Display data
	Switching	Data storage
	Standby mode	Sensor functions
	Temperature	Audible signals
	Power consumption	Others : LED's
	AC mains input current	Others:
	Timing	Others:
	Illumination	Others:
Supp	lementary information :	

Immunity test	Monitored - Checked function(s)/parameter(s) during / after the test	Method
Electrostatic discharge	Pass	Visual
Fast transients	Pass	Visual
Surge transient	Pass	Visual
Injected currents (radio-frequency common mode)	Pass	Visual
Voltage dips and short interruptions	Pass	Visual
Supplementary information :		

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5.3 Electrostatic discharge immunity	VERDICT:	PASS
--------------------------------------	----------	------

Electrostatic discharges (ESD) are the result of persons or objects that accumulate static electricity due to for instance walking on synthetic carpets. The ESD can influence the operation of equipment or damage its electronics, either by a direct discharge or indirectly by coupling or radiation. Both effects are simulated during the tests.

Requirements

Standard	EN 5	EN 55014-2						
Basic standard	EN 6	1000-4-2						
Port under test	Enclo	Enclosure						
Air discharges 1)	\boxtimes	±2 kV	\boxtimes	±4 kV	\boxtimes	±8 kV		kV
Contact discharges 1)		±2 kV	\boxtimes	±4 kV		±8 kV		kV
Number of discharges	≥ 10 per polarity with ≥ 1 sec interval.							
1) Tests with lower voltages are not required.								

Performed tests

Set-up	\boxtimes	Table-top		Floor standing	
Ambient temperature [°C]	23.7°	С	Relat	ive Humidity air [%]	49.1%
Voltage – Mains [V]	230 Vac				
Frequency – Mains [Hz]	50 H	Z			
Operating mode(s) used	Mode	e 1			

Test Point (Location of discharge, see also photo)		Test Voltage [kV] & Polarity	Coupling type	# of applied discharges / polarity	Discharge interval [s]				
\boxtimes	Points on conductive surface as indicated in the picture below.	±2/ ±4	Contact	10	1				
\boxtimes	Points on non-conductive surface as indicated in the picture below.	±2/ ±4/ ±8	Air	10	1				
\boxtimes	HCP top side.	±4	Contact	10	1				
\boxtimes	HCP bottom side.	±4	Contact	10	1				
\boxtimes	VCP right side.	±4	Contact	10	1				
\boxtimes	VCP left side.	±4	Contact	10	1				
\boxtimes	VCP front side.	±4	Contact	10	1				
\boxtimes	VCP rear side.	±4	Contact	10	1				
01	Observation(s) During the test no loss of performance was observed. After the test the EUT functioned as								

Observation(s)	During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance or data was observed.
Supplementary inform	mation:

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5.4 Electrical Fast Transients immunity	VERDICT:	PASS
---	----------	------

The EFT immunity test simulates disturbances by bursts of very short transients caused for example by switching off loads such as an AC motor or bouncing relay contacts. The transients are likely to disturb electronics but less likely to cause damage.

Requirements

Standa	ard	EN 55014-2			
Basic standard EN 61000-4-4					
Pulse characteristics 5/50 ns					
	Port		Test level	Repetition frequency	Duration
\boxtimes	AC input-output power 1)		± 1000 V	5 KHz	2 min. / polarity
	DC input-output power 2)		± 500 V	5 KHz	2 min. / polarity
	Signal and Control lines	3)	± 500 V	5 KHz	2 min. / polarity
1) For	ovtra low voltago a c porte	this testing is only applicable	to porte interfacing w	ith cables when	so total longth may

For extra low voltage a.c ports, this testing is only applicable to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

Performed tests

Voltage – Mains [V]	230 \	230 Vac					
Frequency – Mains [Hz]	50 Hz	7					
Operating mode(s) used	Mode 1						
Test Set-up	\boxtimes	Equipment standing on floor at (0,1 ± 0,01) m above ground plane					
(see annex 3 for photo)		Equipment on the table $(0,1 \pm 0,0)$	01) m	above ground plane			
		Artificial hand applied. Location refer to annex 3.					
Coupling	\boxtimes	Common mode					

Port(s) under test		Test Voltage &Polarity	Repetition Frequency	Test duration / polarity	Injection method			
AC / DC mains powe	r input	1 kV	5 KHz	2 min	\boxtimes	CDN		Clamp
AC / DC power output			5 KHz			CDN		Clamp
Ethernet / LAN			5 KHz			CDN		Clamp
Observation(s) During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance was observed.								

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 $^{^{2)}}$ Not applicable to battery operated appliances that cannot be connected to the mains while in use.

³⁾ Applicable only to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

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5.5 Surge transient immunity VERDICT: PASS

The surge transient immunity test simulates the surges that are caused by over-voltages due to indirect (induced) lightning transients. The pulse is a slow transient with high-energy contents and due to its long duration may cause damage to an unprotected EUT.

Requirements

Standard	EN 55014-2						
Basic standard	EN 61000-4-5						
Pulse characteristics	1,2/50µs Voltage; 8/20µs Current						
Repetition rate	≥ 60 secs. (for each test level and phase angle)						
Number of pulses	5 pulses (at each	polarity and phase a	angle)				
Port		Test level & Pol	Phase angle				
Poil		Line to Line	Line to Earth	[°]			
AC input power 1)	+ 1 kV	N/A	90				
AC input power 1)		- 1 kV	N/A	270			
1) Tests with lower voltages are no	1) Tests with lower voltages are not required.						

Performed tests

Voltage – Mains [V]	230 Vac
Frequency – Mains [Hz]	50 Hz
Operating mode(s) used	Mode 1
Repetition rate	60 secs. (for each test level and phase angle)
Number of pulses	5 pulses (at each polarity and phase angle)
Trainibor or paloco	o paroos (at odori polarity and pridos anglo)

Port(s) under test		Coupling	Test level & Polarity	Phase angle [°]	Remark
\boxtimes	AC mains input power	Line to Neutral	+1 kV	90	
\boxtimes	AC mains input power	Line to Neutral	-1 kV	270	
	AC mains input power	Line to Earth	+2 kV	90	1
	AC mains input power	Line to Earth	-2 kV	270	1
	AC mains input power	Neutral to Earth	+2 kV	90	1
	AC mains input power	Neutral to Earth	-2 kV	270	1
Obse	ervation(s)	During the test no los functioned as intende observed.	•		
Supplementary information:					
1. The EUT does not include an earth port.					

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5.6 Injected currents (RF common mode) immunity VERDICT: PASS

During this test the immunity of the equipment for induced or conducted electromagnetic fields is checked. Fields generated by radio and other transmitters cause RF voltages in long cables like the mains network. This test reproduces these induced disturbing voltages by injecting them to the EUT via the cabling.

Requirements

Standa	ard	EN 55014-2				
Basic	standard	EN 61000-4-6				
	Frequency range	Modulation	Modulation Step size			
	0,15 – 80 MHz	80% AM (1kHz)	≤ 1%	≥ 0,5 s		
\boxtimes	0,15 – 230 MHz	80% AM (1kHz) ≤ 1% ≥ 0,5 s				
	Port		Test I	evel, <i>U</i> o		
\boxtimes	AC input-output power 1)		3 V			
	DC input-output power 2)	3)	1 V			
	Signal and Control lines	4)		1 V		

¹⁾ For extra low voltage a.c ports, this testing is only applicable to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

Performed tests

Frequency ra	nge (a	Modulation (applied)	Step size (applied)			
□ 0,15 – 80 MHz	☑ 0,15 – 230 MHz		80% AM (1kHz)	1%		
Voltage – Mains [V]	230 \	Frequency – Mains [Hz]	50 Hz			
Operating mode(s) used						
Test set-up	Equipment standing on floor at (0,1 ± 0,01) m above ground plane.					
(see annex 3 for photo)	Equipment on the table (0,1 ± 0,01) m above ground plane.					
	\boxtimes	Artificial hand applied. Location refer to annex 3.				

Port(s) under test		Test Level (applied)	Injection method	Dwell time (applied)	Remark	
AC mains power input		3 V	CDN-M2	3 s	1	
Observation(s) During the test no loss of performance was observed. After the test the EUT function as intended. No unacceptable loss of performance or data was observed.						
Supplementary information:						

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²⁾ Not applicable to battery operated appliances that cannot be connected to the mains while in use.

³⁾ Applicable to battery operated appliances that can be connected to the mains while in use, or to appliances for which the length of d.c. cables may exceed 3 m according to the manufacturer's functional specification.

⁴⁾ Applicable only to ports interfacing with cables whose total length may exceed 3 m according to the manufacturer's functional specification.

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5.7 Power supply interruptions and dips immunity VERDICT: PASS

The purpose of the test is to verify the immunity of the equipment against voltage dips and voltage interruptions. It helps to ensure that the equipment functions properly (as expected and safely) with power supply fluctuations. Voltage dips and interruptions are caused by faults in the LV, MV, HV networks (short-circuit or ground faults).

Requirements

Standard	EN 55014-2				
Basic standard	EN 61000-4-11				
# of dips & interruptions	3 dips / interruptions for each test level and phase angle				
Interval between events	≥ 10 seconds				
Port	Test level 1)	Period (Cycles)		Performance Criteria	
Poit		50 Hz	60 Hz	renormance Cinena	
AC input power port	U _{NOM} – 100%	0,5 0,5		C; Refer to the chapter 5.1 for details.	
AC input power port	U _{NOM} – 60%	10 12		C; Refer to the chapter 5.1 for details.	
AC input power port	U _{NOM} – 30%	25	30	C; Refer to the chapter 5.1 for details.	

¹⁾ Changes to the voltage level shall occur at a zero crossing point in the a.c. voltage waveform.

NOTE: Where the equipment has a rated voltage range the following shall apply:

- If the voltage range does not exceed 20% of the lower voltage specified for the rated voltage range. A single voltage within that range may be selected for testing.
- In all other cases, the test procedure shall be applied for both the lowest and highest voltages declared in the voltage range.

Performed tests

II [\/]	Terminal	Voltage dip	Duration	[cycles]	Repetion rate	Number of dips per test	Phase angle
U _{NOM} [V _{AC}]	Temma	[% U _{NOM}]	50 Hz	60 Hz	[s]		[°]
230	L-N	0	0,5	/	10	3	0, 180
230	L-N	40	10	/	10	3	0, 180
230	L-N	70	25	/	10	3	0, 180
Operating mo	ode(s) used	Mode 1					
Observation(s) During the test no loss of performance was observed. After the test the EUT functioned as intended. No unacceptable loss of performance was observed.							
Supplementary information:							

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6 IDENTIFICATION OF THE EQUIPMENT UNDER TEST

EUT PHOTOS





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7 ANNEX 1 - MEASUREMENT UNCERTAINTIES

The table(s) below show(s) measurment uncertainties of the EMC test set-ups. The reported expanded uncertainties are based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95%.

Emission tests	Uncertainty	Ucispr		
RF Conducted disturbance (mains port) 9 kHz – 30MHz	AMN: R&S ESH2-Z5	3,38 dB	3,44 dB	
Disturbance power, 30 MHz – 300 MHz	3,92 dB	4,50 dB		
LF harmonic current emissions	0,2%	na		
LF voltage fluctuations	LF voltage fluctuations			

Immunity tests	Uncertainty
Electrostatic discharge	U _{peak} =6%, U _{30ns} =6%, U _{60ns} =6%, U _{rt} =8%
Fast transients	Utr=7%, Upw=5%, Ubp=2%, Ubd=2%
Surges	U _{peak} =5%, U _{ft} =5%, U _{dt} =4%
Injected currents (radio-frequency common mode)	1,71dB
Voltage dips and short interruptions	U _{out} =2%, U _f =4%, U _{r-d} =4%

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8 ANNEX 2 - USED EQUIPMENT

Equipment	Manufacturer	Model No.	Serial No.	Cal. due date
EMI test receiver	R&S	ESCI	101351	2019/08/03
2-line V-network	R&S	ENV216	101620	2019/08/03
EMI absorbing clamp	SCHWARZBECK	MDS 21B	4183	2019/08/03
Harmonic currents and flick tester	California Instruments	CTS	1306A00135	2019/05/15
AC power source	California Instruments	5001iX-CTS-400	1306A00135	2019/05/15
ESD generator	TESEQ	NSG 435	6716	2019/08/23
EFT, Surge, DIPS all-in-one	TESEQ	NSG-3040-MF	2006/EFT:0535 /SURGE:1234 /DIPS:2062	2019/08/01
Compact immunity test system (RF)	TESEQ	NSG 4070-30	35895	2019/08/03
Coupling decoupling network (CDN)	TESEQ	CDN M016S	34640	2019/08/03
Attenuator	TESEQ	ANT 6050	34847	2019/08/03

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9 **ANNEX 3 - TEST PHOTOS**

Conducted disturbance voltage at mains terminals



Disturbance power



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Harmonic current emissions & Flicker



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